

# **BUL1102E**

# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

#### PRELIMINARY DATA

- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

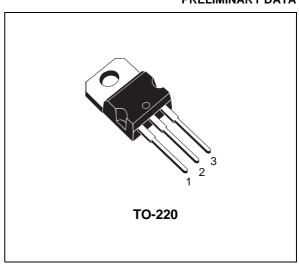
#### **APPLICATIONS**

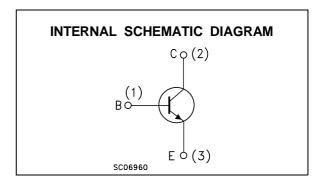
 FOUR LAMP ELECTRONIC BALLAST FOR: 120 V MAINS IN PUSH-PULL CONFIGURATION; 277 V MAINS IN HALF BRIDGE CURRENT FEED CONFIGURATION.

#### **DESCRIPTION**

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining a wide RBSOA.

Thanks to an increased intermediate layer, it has an intrinsic ruggedness which enables the transistor to withstand a high collector current level during Breakdown condition, without using the transil protection usually necessary in typical converters for lamp ballast.





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	1100	V
V <sub>CEO</sub>	Collector-Emitter Voltage (I <sub>B</sub> = 0)	450	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	12	V
Ic	Collector Current	4	А
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> <5 ms)	8	А
I <sub>B</sub>	Base Current	2	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> <5 ms)	4	А
P <sub>tot</sub>	Total Dissipation at Tc = 25 °C	70	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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#### THERMAL DATA

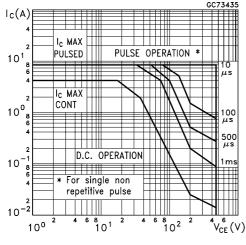
R <sub>thj-case</sub>	Thermal Resistance Junction-Case	Max	1.78	°C/W	
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# **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

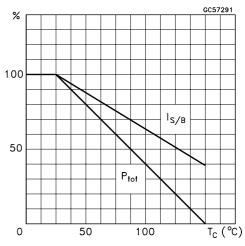
Symbol	Parameter	Test	Conditions	Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = 1100 V				100	μΑ
I <sub>EBO</sub>	Emitter Cut-off Current (I <sub>B</sub> = 0)	V <sub>EB</sub> = 12 V				1	mA
V <sub>CEO(sus)</sub> *	Collector-Emitter Sustaining Voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = 100 mA		450			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 2 A	$I_B = 400 \text{ mA}$			1.5	V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	I <sub>C</sub> = 2 A	I <sub>B</sub> = 400 mA			1.5	V
h <sub>FE</sub> *	DC Current Gain	· ·	$V_{CE} = 5 V$ $V_{CE} = 5 V$	35 10		70 20	
t <sub>s</sub>	RESISTIVE LOAD Storage Time Fall Time	$I_C = 2.5 \text{ A}$ $I_{B1} = 0.5 \text{ A}$ $T_P = 30 \mu\text{s}$	$V_{CC} = 250 \text{ V}$ $I_{B2} = 1 \text{ A}$ (see figure 2)			2.5 300	μs ns
E <sub>sb</sub>	Avalanche Energy	$L = 2 \text{ mH}$ $I_{BR} \le 2.5 \text{A}$ (see figure 1)	C = 1.8 nF 25°C < T <sub>C</sub> <125°C	6			mJ

<sup>\*</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

## Safe Operating Areas



## **Derating Curve**



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### Reverse Biased SOA

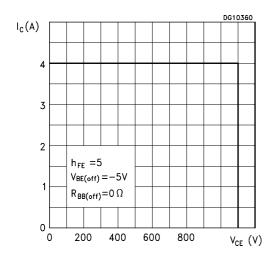


Figure 1: Energy Rating Test Circuit

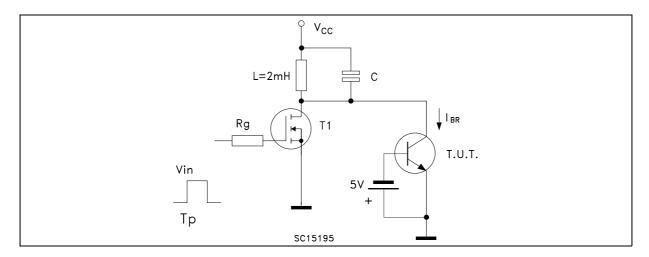
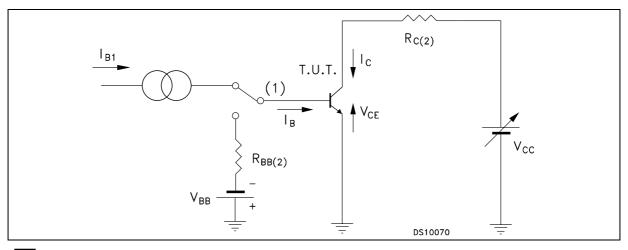


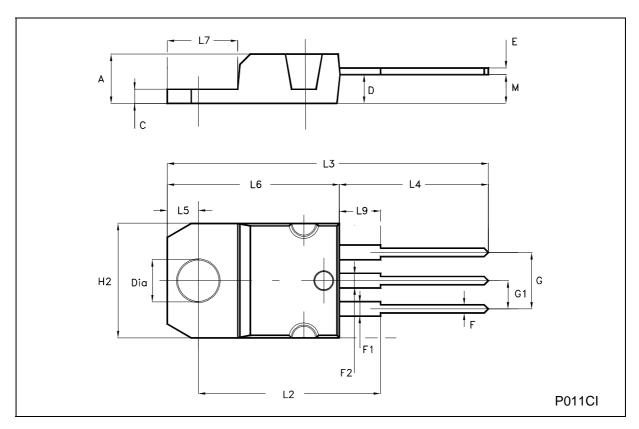
Figure 2: Resistive Load Switching Test Circuit



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# **TO-220 MECHANICAL DATA**

DIM.	mm			inch			
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Α	4.40		4.60	0.173		0.181	
С	1.23		1.32	0.048		0.052	
D	2.40		2.72	0.094		0.107	
E	0.49		0.70	0.019		0.027	
F	0.61		0.88	0.024		0.034	
F1	1.14		1.70	0.044		0.067	
F2	1.14		1.70	0.044		0.067	
G	4.95		5.15	0.194		0.202	
G1	2.40		2.70	0.094		0.106	
H2	10.00		10.40	0.394		0.409	
L2		16.40			0.645		
L4	13.00		14.00	0.511		0.551	
L5	2.65		2.95	0.104		0.116	
L6	15.25		15.75	0.600		0.620	
L7	6.20		6.60	0.244		0.260	
L9	3.50		3.93	0.137		0.154	
М		2.60			0.102		
DIA.	3.75		3.85	0.147		0.151	



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